

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of
Bednasz et al.

Serial No.: **10/776,789**

Filed: **11 February 2004**

For: **GSM Radiated Sensitivity Measurement
Technique**

Docket No: **2002-050**

PATENT PENDING

Examiner: Mr. Yuwen Pan

Group Art Unit: 2618

Confirmation No.: 3243

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RESPONSE TO EX PARTE QUAYLE COMMUNICATION

In response to the Ex Parte Quayle communication mailed 25 July 2008, Applicant submits the following response.